ISOMETER® IR155-4203/IR155-4204

Insulation monitoring device (IMD) for unearthed DC drive systems (IT systems) in electric vehicles

Version V004





Insulation monitoring device (IMD) for unearthed DC drive systems (IT systems) in electric vehicles



Device features

- Suitable for 12 V and 24 V systems
- · Automatic device self test
- Continuous measurement of the insulation resistance 0...10 $M\Omega$
 - Response time for the first measurement of the system state (SST) is < 2 s after switching the supply voltage on
 - Response time < 20 s for insulation resistance measurement (DCP)
- Automatic adaptation to the existing system leakage capacitance (≤ 1 μF)
- Detection of earth faults and interruption of the earth connection
- Insulation monitoring of AC and DC insulation faults for unearthed systems (IT systems) 0...1000 V
- Undervoltage detection for voltages below 500 V (adjustable at factory by Bender)
- Short-circuit proof outputs for:
 - Fault detection (high-side output)
 - Measured value (PWM 5...95 %) and status (f = 10...50 Hz) at high or inverted low-side driver (M_{HS}/M_{LS} output)
- Protective coating (SL 1307 FLZ)

Approvals



ATTENTION



Observe precautions for handling electrostatic sensitive devices.

Handle only at safe work stations.

ATTENTION



The device is monitoring HIGH VOLTAGE.

Be aware of HIGH VOLTAGE near to the device.

Product description

The ISOMETER® IR155-4203/-4204 monitors the insulation resistance between the insulated and active HV-conductors of an electrical drive system ($U_n = DC\ 0\ V...1000\ V$) and the reference earth (chassis ground \blacktriangleright Kl.31). The patented measurement technology is used to monitor the condition of the insulation on the DC side as well as on the AC motor side of the electrical drive system. Existing insulation faults will be signalled reliably, even under high system interferences, which can be caused by motor control processes, accelerating, energy recovering etc.

Due to its space-saving design and optimised measurement technology, the device is optimised for use in hybrid or fully electric vehicles. The device meets the increased automotive requirements with regard to the environmental conditions (e.g. temperatures and vibration, EMC...).

The fault messages (insulation fault at the HV-system, connection or device error of the IMD) will be provided at the integrated and galvanic isolated interface (high- or low-side driver). The interface consists of a status output (OK_{HS} output) and a measurement output (M_{HS}/M_{LS} output). The status output signalises errors or that the system is error free, i.e the "good" condition as shown by the "Operating principle PWM driver" diagram on page 5. The measurement output signalises the actual insulation resistance. Furthermore, it is possible to distinguish between different fault messages and device conditions, which are base frequency encoded.

Function

The ISOMETER® IR155-4203/-4204 generates a pulsed measuring voltage, which is superimposed on the IT system via terminals L+/L- and E/KE. The latest measured insulation condition is available as a pulse-width-modulated (PWM) signal at terminals $M_{\rm HS}$ (for IR155-4204) or $M_{\rm LS}$ (for IR155-4203). The connection between the terminals E/KE and the chassis ground (\blacktriangleright KI.31) is continuously monitored. Therefore it is necessary to install two separated conductors from the terminals E or KE to chassis ground.



Connection monitoring of the earth terminals E/KE is specified for $R_F \le 4 M\Omega$ if the ISOMETER® is connected as shown in the application diagram on page 3.

Once power is switched on, the device performs an initialisation and starts the system state (SST) measurement. The ISOMETER® provides the first estimated insulation resistance during a maximum time of 2 seconds. The DCP measurement (> continuous measurement method) starts subsequently. Faults in the connecting wires or functional faults will be automatically recognised and signalled.

During operation, a self test is carried out automatically every five minutes. The interfaces will not be influenced by these self tests.



Connection monitoring of the earth terminals E/KE may not work as intended when $R_F > 4 M\Omega$ if the supply terminals (Kl.15/Kl.31) are not galvanically isolated from the chassis earth (Kl.31).

Standards

ds and regulations*	* Normative
2014-12	The device w
2010-06	test procedu
2004-04	customer red
2011-12	The norm IEC
2006-11	creating the f
2006-08	test button at
2010-03	The device in
2010-04	dump protec
0 revision 5)	central prote
2009/19/EG/EC	central prote
Z/AD:2010	
Db:2006	
Nb:2010	
Fh:2009	
	2014-12 2010-06 2004-04 2011-12 2006-11 2006-08 2010-03 2010-04 0 revision 5) 2009/19/EG/EC Z/AD:2010 Db:2006 Nb:2010

Ea:2010

* Normative exclusion

The device went through an automotive test procedure in combination of multi customer requirements reg. ISO16750-x.
The norm IEC61557-8 will be fulfilled by

The norm IEC61557-8 will be fulfilled by creating the function for LED warning and test button at the customer site if necessary.

The device includes no surge and load dump protection above 50 V. An additional central protection is necessary.

Abbreviations

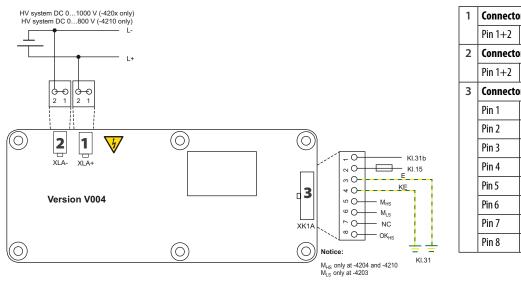
DIN EN 60068-2-27

DCP	Direct Current Pulse
SST	Speed Start Measuring



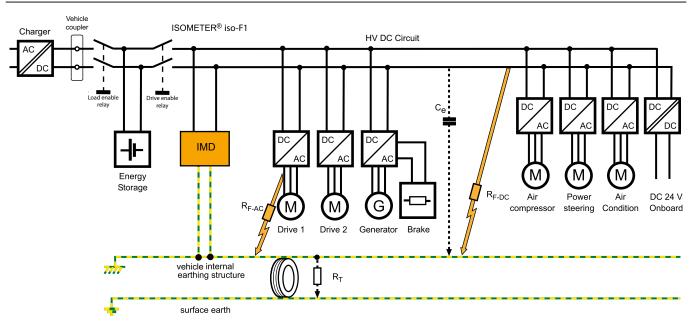
AC/DC

Wiring diagrams



1	Connector XLA+		
	Pin 1+2	L+	Line Voltage
2	Connector XLA-		
	Pin 1+2	L-	Line Voltage
3	Connecto	r XK1A	
	Pin 1	Kl. 31	Chassis ground/electronic ground
	Pin 2	Kl. 15	Supply voltage
	Pin 3	Kl. 31	Chassis ground
	Pin 4	Kl. 31	Chassis ground (separate line)
	Pin 5	M _{HS}	Data Out, PWM (high side)
	Pin 6	M _{LS}	Data Out, PWM (low side)
	Pin 7	n.c.	
	Pin 8	<i>OK</i> _{HS}	Status Output (high side)

Typical application





Technical data

Insulation coordination acc. to	IEC 60664-1	Time response	
Protective separation (reinforced in		Response time t_{an} (OK_{HS} ; SST)	$t_{an} \le 2 \text{ s (typ.} < 1 \text{ s at } U_n > 100 \text{ V})$
	between (L+/L-) — (Kl. 31, Kl. 15, E, KE, M _{HS} , M _{LS} , OK _{HS})	Response time t_{an} (OK_{HS} ; DCP)	(a) = 25 (yp. 1.5 at 5)
Voltage test	AC 3500 V/1 min	(when changing over from $R_F = 10 \text{ M}\Omega$ to	o $R_{\rm an}/2$; at $C_{\rm e} = 1 \mu \text{F}$; $U_{\rm n} = \text{DC } 1000 \text{V}$)
			$t_{\rm an} \le 20 \text{s} (\text{at} F_{\rm ave} = 10^*)$
Supply/IT system being monitor			$t_{\rm an} \le 17.5 \mathrm{s} (\mathrm{at}F_{\rm ave} = 9)$
Supply voltage U_S	DC 1036 V		$t_{\rm an} \le 17.5 {\rm s} ({\rm at} F_{\rm ave} = 8)$
Max. operating current Is	150 mA		$t_{\rm an} \le 15 \text{s} (\text{at } F_{\rm ave} = 7)$
Max. current I _k	2 A		$t_{an} \le 12.5 \text{ s (at } F_{ave} = 6)$
	6 A/2 ms inrush current		$t_{an} \le 12.5 \text{ s (at } F_{ave} = 5)$
HV voltage range (L+/L-) U_n	AC 01000 V (peak value)		$t_{\rm an} \leq 10 \rm s (at F_{\rm ave} = 4)$
	0660 V r.m.s. (10 Hz1 kHz)		$t_{an} \le 7.5 \text{ s (at } F_{ave} = 3)$
	DC 01000 V		$t_{an} \leq 7.5 \text{ s (at } F_{ave} = 2)$
Power consumption	< 2 W		$t_{an} \le 5 \text{ s (at } F_{ave} = 1)$
Response values			during the self test $t_{an} + 10$ s
Response value hysteresis (DCP)	25 %	Switch-off time t _{ab} (OK _{HS} ; DCP)	
Response value R_{an}	100 kΩ1 MΩ	(when changing over from $R_{an}/2$ to $R_F =$	10 MΩ; at $C_e = 1 \mu F$; $U_n = DC 1000 V$
Undervoltage detection	0500 V		$t_{ab} \le 40 \text{ s (at } F_{ave} = 10)$
	0500 1		$t_{ab} \le 40 \text{ s (at } F_{ave} = 9)$
Measuring range			$t_{ab} \le 33 \text{ s (at } F_{ave} = 8)$
Measuring range	010 ΜΩ		$t_{ab} \le 33 \text{ s (at } F_{ave} = 7)$
Undervoltage detection	0500 V default setting: 0 V (inactive)		$t_{ab} \le 33 \text{ s (at } F_{ave} = 6)$
Relative uncertainty			$t_{ab} \le 26 \text{ s (at } F_{ave} = 5)$
$SST (\leq 2 s)$	$good > 2* R_{an}; bad < 0.5* R_{an}$		$t_{\rm ab} \le 26 \text{s} (\text{at} F_{\rm ave} = 4)$
Relative uncertainty DCP	085 kΩ ▶ ±20 kΩ		$t_{ab} \le 26 \text{ s (at } F_{ave} = 3)$
(default setting 100 kΩ)	100 kΩ10 MΩ ▶ ±15%		$t_{ab} \le 20 \text{ s (at } F_{ave} = 2)$
Relative uncertainty output M (fur			$t_{ab} \le 20 \text{ s (at } F_{ave} = 1)$
	(10 Hz; 20 Hz; 30 Hz; 40 Hz; 50 Hz)	2 4 61 16	during a self test $t_{ab} + 10 \text{ s}$
Relative uncertainty		Duration of the self test	10 s
undervoltage detection	$U_{\rm n} \ge 100 \text{V} \implies \pm 10 \%; \text{ at } U_{\rm n} \ge 300 \text{V} \implies \pm 5 \%$		(every five minutes; should be added to t_{an}/t_{ab})
Relative uncertainty (SST)	"Good condition" $\geq 2 * R_{an}$	Measuring circuit	
	"Bad condition" $\leq 0.5 * R_{an}$	System leakage capacitance C _e	 ≤ 1 µF
		Smaller measurement range and increase	,
No Insulation fault (high)			(e.g. max. range 1 MΩ @ 3 μF,
(3)	Y	$t_{an} =$	68 s when changing over from R_F 1 MΩ to $R_{an}/2$)
Insulation fault		Measuring voltage $U_{\rm M}$	±40 V
(low)		Measuring current I_{M} at $R_{F} = 0$	±33 μA
·	$_{50\text{k}\Omega}$ Response value = $_{200\text{k}\Omega}$ 10MΩ	Impedance Z _i at 50 Hz	≥ 1.2 MΩ
Relative uncertainty DCP	100 kΩ10 MΩ ±15 %	Internal DC resistance R _i	≥ 1.2 MΩ
nelative uncertainty bei	100 kΩ1.2 MΩ \blacktriangleright ±15 % to ±7 %	*5 40:	11 1 1 1 1 1 1
	1.2 MΩ ► ±7 %	* $F_{\text{ave}} = 10$ is recommended for electric a	and nybrid venicles
	1.210 M Ω > ±7 % to ±15 %		
	10 MΩ > ±15 %		
	+15%		
	+7%		
	0		
	-7%		

^{0...85} kΩ ▶ ±20 kΩ +1.5ΜΩ +20kΩ +15kΩ -15kΩ -20kΩ -1.5MΩ 85kΩ100kΩ 1.2ΜΩ

1.2ΜΩ

10ΜΩ

-15% -100kΩ

Absolute uncertainty



Output

Measurement output (M)

 $M_{\rm HS}$ switches to $U_{\rm S}-2$ V (4204)

(external pull-down resistor to Kl. 31 necessary 2.2 k Ω)

M_{LS} switches to KI. 31 + 2 V (4203)

(external pull-up resistor to KI. 15 regired 2.2 $k\Omega$

0 Hz \blacktriangleright Hi > short-circuit to $U_{\rm b}$ + (Kl. 15); Low > IMD off or short-circuit to Kl. 31

10 Hz ➤ Normal condition
Insulation measurement DCP;
starts two seconds after power on;
First successful insulation measurement at ≤ 17.5 s
PWM active 5...95 %

20 Hz ➤ undervoltage condition
Insulation measurement DCP (continuous measurement);
starts two seconds after power on;
PWM active 5...95 %
First successful insulation measurement at ≤ 17.5 s
Undervoltage detection 0...500 V

(Bender configurable) **30 Hz** \blacktriangleright Speed start measurement Insulation measurement (only good/bad evaluation) starts directly after power on ≤ 2 s;

PWM 5...10 % (good) and 90...95 % (bad)

40 Hz ▶ Device error

Device error detected: PWM 47.5...52.5 %

50 Hz ► Connection fault earth Fault detected on the earth connection (Kl. 31)

PWM 47.5...52.5 %

Status output (OK_{HS})

 OK_{HS} switches to $U_S - 2$ V (external pull-down resistor to Kl. 31 required 2.2 k Ω)

High ► No fault; R_F > response value
Low ► Insulation resistance ≤ response value detected;
Device error; Fault in the earth connection
Undervoltage detected or device switched off

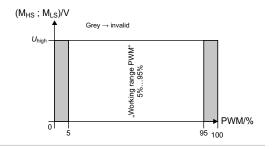
Operating principle PWM driver

Condition "Normal" and "Undervoltage detected" (10 Hz; 20 Hz)

Duty cycle 5 % = > 50 M Ω (∞) Duty cycle 50 % = 1200 k Ω Duty cycle 95 % = 0 k Ω

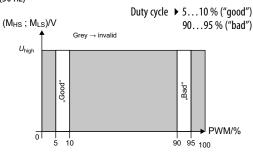
$$R_{\rm F} = \frac{90 \% \times 1200 \text{ k}\Omega}{dc_{\rm max} - 5\%} - 1200 \text{ k}\Omega$$

 dc_{meas} = measured duty cycle (5 %...95 %)



Operating principle PWM driver

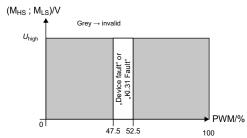
Condition "SST" (30 Hz)



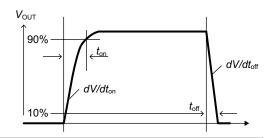
Operating principle PWM driver

Condition "Device error" and "KI.31 fault" (40 Hz; 50 Hz;)

Duty cycle ▶ 47.5...52.5 %



Load current /L	80 mA
Turn-on time ► to 90 % V _{out}	max. 125 μs
Turn-off time ▶ to 10 % V _{out}	max. 175 µs
Slew rate on ▶ 1030 % V _{out}	max. 6 V/µs
Slew rate off ▶ 7040 % V _{out}	max. 8 V/µs
Timing 4204 (inverse to 4203)	·



FMC

EMC		
Load dump protection		< 50 V
Measurement method		Bender-DCP technology
Factor averaging		
F _{ave} (output M)		110 (factory set: 10)
ESD protection		
Contact discharge – dire	ectly to terminals	≤ 10 kV
Contact discharge - ind	irectly to environment	≤ 25 kV
Air discharge – handling	g of the PCB	≤ 6 kV
Connection		
Connectors		Samtec Mini Mate Housing, IPD1-08-S-K
		(KI. 31B, KI.15, KE, E, M _{HS} , M _{LS} , OK _{HS})
	Mole	x Mini Fit Jr. Housing, 39-01-2025, (L+, L-)
Crimp contacts	Samtec Mini	Mate Gold, CC79R2024-01-L, AWG 2024
	N	olex Mini Fit Jr. Gold. 39-00-0089. AWG 16

General data

Necessary crimping tool (Molex)	2002182200
Necessary crimping tool 20 – 30 AWG (Samtec)	CAT-HT-179-2030-13
Operating mode/mounting	continuous operation/any position
Temperature range	-40+105 ℃
Voltage failure	≤ 2 ms
Flammability class acc. to	UL 94 V-0

Mounting

M4 metal screws with locking washers between screw head and PCB. Torx, T20 with a maximum tightening torque of 4 Nm for the screws. Furthermore, a maximum of 10 Nm tightening torque to the PCB at the mounting points.

Mounting and connector kits are not included in delivery, but are available as accessories. The maximum diameter of the mounting points is 10 mm.

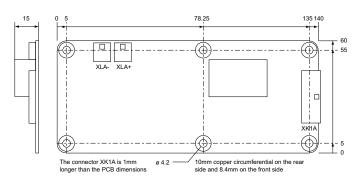
Before mounting the device, ensure sufficient insulation between the device and the vehicle or the mounting points (min. 11.4 mm to other parts). If the device is mounted on a metal or conductive subsurface, this subsurface has to be at earth potential (Kl.31; vehicle mass).

Deflection	max. 1 % of the length or width of the PCB
Coating	thick-film lacquer
Weight	52 g ±2 g

Dimension diagram

Dimensions in mm

PCB dimensions (L x W x H) 140 mm x 60 mm x 15 mm



Ordering information

Parameters	Response value R _{an}	F ave	Undervoltage detection	Measured value output	Туре	Art. No.		
Continuously set value	100 k0	10	300 V	Low-side	IR155-4203	B91068141		
Continuously set value	100 kΩ	10	10	O KIZ	0 V (inactive)	High-side	IR155-4204	B91068142
Customer-specific setting	100 kΩ1 MΩ	110	0 V500 V	Low-side	IR155-4203	B91068141C		
				High-side	IR155-4204	B91068142C		

Accessories

Type designation	Art. No.
Fastening set	B91068500
Connector set IR155-42xx	B91068502

Example for ordering

IR155-4204-100k Ω -0V + B91068142 IR155-4204-200k Ω -100V + B91068142C

The parameters acc. response value and under voltage protection have always to be added or included to an order.



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Subject to change!
The specified standards take into account the

edition valid until 06.2024 unless otherwise indicated.